

## N-channel 650 V, 0.075 $\Omega$ typ., 22.5 A MDmesh™ M5 Power MOSFET in a PowerFLAT™ 8x8 HV package

Datasheet - production data

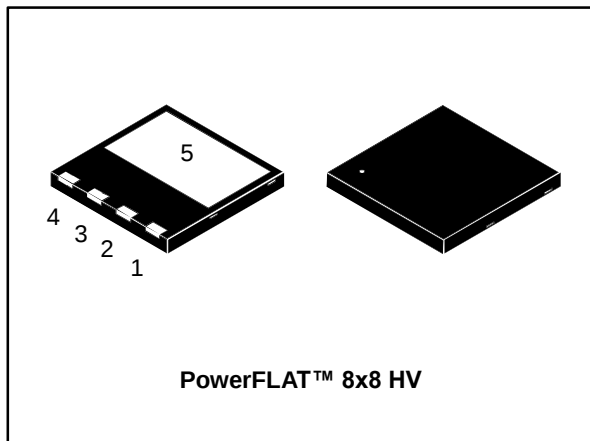
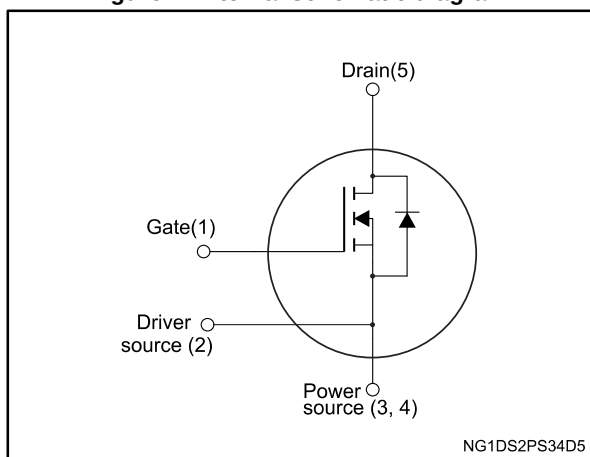


Figure 1: Internal schematic diagram



### Features

| Order code | $V_{DS}$ @ $T_{Jmax.}$ | $R_{DS(on)}$ max. | $I_D$  | $P_{TOT}$ |
|------------|------------------------|-------------------|--------|-----------|
| STL45N65M5 | 710 V                  | 0.086 $\Omega$    | 22.5 A | 160 W     |

- Extremely low  $R_{DS(on)}$
- Low gate charge and input capacitance
- Excellent switching performance
- 100% avalanche tested

### Applications

- Switching applications

### Description

This device is an N-channel Power MOSFET based on the MDmesh™ M5 innovative vertical process technology combined with the well-known PowerMESH™ horizontal layout. The resulting product offers extremely low on-resistance, making it particularly suitable for applications requiring high power and superior efficiency.

Table 1: Device summary

| Order code | Marking | Package           | Packing       |
|------------|---------|-------------------|---------------|
| STL45N65M5 | 45N65M5 | PowerFLAT™ 8x8 HV | Tape and reel |

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## Contents

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# 1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol            | Parameter                                                | Value      | Unit |
|-------------------|----------------------------------------------------------|------------|------|
| $V_{DS}$          | Drain-source voltage                                     | 650        | V    |
| $V_{GS}$          | Gate-source voltage                                      | ±25        | V    |
| $I_D^{(1)}$       | Drain current (continuous) at $T_{case} = 25\text{ °C}$  | 22.5       | A    |
|                   | Drain current (continuous) at $T_{case} = 100\text{ °C}$ | 18         |      |
| $I_{DM}^{(1)(2)}$ | Drain current (pulsed)                                   | 90         | A    |
| $P_{TOT}^{(1)}$   | Total dissipation at $T_{case} = 25\text{ °C}$           | 160        | W    |
| $I_D^{(3)}$       | Drain current (continuous) at $T_{amb} = 25\text{ °C}$   | 3.8        | A    |
|                   | Drain current (continuous) at $T_{amb} = 100\text{ °C}$  | 2.4        |      |
| $P_{TOT}^{(3)}$   | Total dissipation at $T_{amb} = 25\text{ °C}$            | 2.8        | W    |
| $dv/dt^{(4)}$     | Peak diode recovery voltage slope                        | 15         | V/ns |
| $T_{stg}$         | Storage temperature                                      | -55 to 150 | °C   |
| $T_j$             | Operating junction temperature                           |            |      |

**Notes:**

- (1) The value is rated according to  $R_{thj-case}$  and limited by package.  
 (2) Pulse width limited by safe operating area.  
 (3) When mounted on a 1-inch<sup>2</sup> FR-4, 2oz Cu board.  
 (4)  $I_{SD} \leq 22.5\text{ A}$ ,  $di/dt \leq 400\text{ A}/\mu\text{s}$ ,  $V_{DD} = 400\text{ V}$ ,  $V_{DS(peak)} < V_{(BR)DSS}$ .

Table 3: Thermal data

| Symbol              | Parameter                           | Value | Unit |
|---------------------|-------------------------------------|-------|------|
| $R_{thj-case}$      | Thermal resistance junction-case    | 0.78  | °C/W |
| $R_{thj-amb}^{(1)}$ | Thermal resistance junction-ambient | 45    |      |

**Notes:**

- (1) When mounted on a 1-inch<sup>2</sup> FR-4, 2oz Cu board.

Table 4: Avalanche characteristics

| Symbol         | Parameter                                       | Value | Unit |
|----------------|-------------------------------------------------|-------|------|
| $I_{AR}^{(1)}$ | Avalanche current, repetitive or not repetitive | 8     | A    |
| $E_{AS}^{(2)}$ | Single pulse avalanche energy                   | 810   | mJ   |

**Notes:**

- (1) Pulse width limited by  $T_{jmax}$ .  
 (2) starting  $T_j = 25\text{ °C}$ ,  $I_D = I_{AR}$ ,  $V_{DD} = 50\text{ V}$ .

## 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Table 5: Static

| Symbol               | Parameter                         | Test conditions                                                            | Min. | Typ.  | Max.  | Unit |
|----------------------|-----------------------------------|----------------------------------------------------------------------------|------|-------|-------|------|
| V <sub>(BR)DSS</sub> | Drain-source breakdown voltage    | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1 mA                               | 650  |       |       | V    |
| I <sub>DSS</sub>     | Zero gate voltage drain current   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 650 V                             |      |       | 1     | μA   |
|                      |                                   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 650 V, T <sub>case</sub> = 125 °C |      |       | 100   | μA   |
| I <sub>GSS</sub>     | Gate-body leakage current         | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±25 V                             |      |       | ±100  | nA   |
| V <sub>GS(th)</sub>  | Gate threshold voltage            | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                | 3    | 4     | 5     | V    |
| R <sub>DS(on)</sub>  | Static drain-source on-resistance | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 14.5 A                            |      | 0.075 | 0.086 | Ω    |

Table 6: Dynamic

| Symbol                            | Parameter                                    | Test conditions                                                                                                                       | Min. | Typ. | Max. | Unit |
|-----------------------------------|----------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| C <sub>iss</sub>                  | Input capacitance                            | V <sub>DS</sub> = 100 V, f = 1 MHz, V <sub>GS</sub> = 0 V                                                                             | -    | 3470 | -    | pF   |
| C <sub>oss</sub>                  | Output capacitance                           |                                                                                                                                       | -    | 82   | -    |      |
| C <sub>rss</sub>                  | Reverse transfer capacitance                 |                                                                                                                                       | -    | 7    | -    |      |
| C <sub>o(er)</sub> <sup>(1)</sup> | Equivalent output capacitance energy related | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0 to 520 V                                                                                   | -    | 79   | -    | pF   |
| C <sub>o(tr)</sub> <sup>(2)</sup> | Equivalent output capacitance time related   |                                                                                                                                       | -    | 280  | -    |      |
| R <sub>G</sub>                    | Intrinsic gate resistance                    | f = 1 MHz, I <sub>D</sub> = 0 A                                                                                                       | -    | 2    | -    | Ω    |
| Q <sub>g</sub>                    | Total gate charge                            | V <sub>DD</sub> = 520 V, I <sub>D</sub> = 17.5 A, V <sub>GS</sub> = 10 V (see <a href="#">Figure 16: "Gate charge test circuit"</a> ) | -    | 82   | -    | nC   |
| Q <sub>gs</sub>                   | Gate-source charge                           |                                                                                                                                       | -    | 18.5 | -    |      |
| Q <sub>gd</sub>                   | Gate-drain charge                            |                                                                                                                                       | -    | 35   | -    |      |

### Notes:

<sup>(1)</sup> Energy related is defined as a constant equivalent capacitance giving the same stored energy as C<sub>oss</sub> when V<sub>DS</sub> increases from 0 to 80% V<sub>DSS</sub>

<sup>(2)</sup> Time related is defined as a constant equivalent capacitance giving the same charging time as C<sub>oss</sub> when V<sub>DS</sub> increases from 0 to 80% V<sub>DSS</sub>

Table 7: Switching times

| Symbol              | Parameter          | Test conditions                                                                                                                                                | Min. | Typ. | Max. | Unit |
|---------------------|--------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| t <sub>d(v)</sub>   | Voltage delay time | V <sub>DD</sub> = 400 V, I <sub>D</sub> = 22.5 A<br>R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V (see <a href="#">Figure 20: "Switching time waveform"</a> ) | -    | 79.5 | -    | ns   |
| t <sub>r(v)</sub>   | Voltage rise time  |                                                                                                                                                                | -    | 11   | -    |      |
| t <sub>f(i)</sub>   | Current fall time  |                                                                                                                                                                | -    | 9.3  | -    |      |
| t <sub>c(off)</sub> | Crossing time      |                                                                                                                                                                | -    | 16   | -    |      |

Table 8: Source-drain diode

| Symbol             | Parameter                     | Test conditions                                                                                                                                                                                                                        | Min. | Typ. | Max. | Unit          |
|--------------------|-------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|------|---------------|
| $I_{SD}^{(1)}$     | Source-drain current          |                                                                                                                                                                                                                                        | -    |      | 22.5 | A             |
| $I_{SDM}^{(1)(2)}$ | Source-drain current (pulsed) |                                                                                                                                                                                                                                        | -    |      | 90   | A             |
| $V_{SD}^{(3)}$     | Forward on voltage            | $V_{GS} = 0 \text{ V}$ , $I_{SD} = 22.5 \text{ A}$                                                                                                                                                                                     | -    |      | 1.5  | V             |
| $t_{rr}$           | Reverse recovery time         | $I_{SD} = 22.5 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 100 \text{ V}$ (see <a href="#">Figure 17: "Test circuit for inductive load switching and diode recovery times"</a> )                                      | -    | 346  |      | ns            |
| $Q_{rr}$           | Reverse recovery charge       |                                                                                                                                                                                                                                        | -    | 6    |      | $\mu\text{C}$ |
| $I_{RRM}$          | Reverse recovery current      |                                                                                                                                                                                                                                        | -    | 35   |      | A             |
| $t_{rr}$           | Reverse recovery time         | $I_{SD} = 22.5 \text{ A}$ , $di/dt = 100 \text{ A}/\mu\text{s}$ , $V_{DD} = 100 \text{ V}$ , $T_J = 150 \text{ }^\circ\text{C}$ (see <a href="#">Figure 17: "Test circuit for inductive load switching and diode recovery times"</a> ) | -    | 432  |      | ns            |
| $Q_{rr}$           | Reverse recovery charge       |                                                                                                                                                                                                                                        | -    | 8.4  |      | $\mu\text{C}$ |
| $I_{RRM}$          | Reverse recovery current      |                                                                                                                                                                                                                                        | -    | 39   |      | A             |

**Notes:**

- (1) The value is rated according to  $R_{thj-case}$  and limited by package.  
(2) Pulse width is limited by safe operating area.  
(3) Pulse test: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

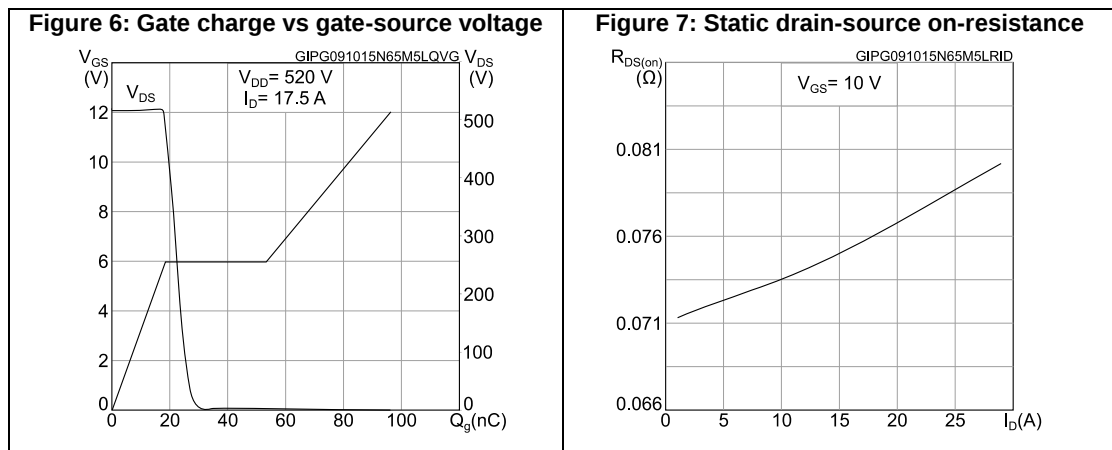
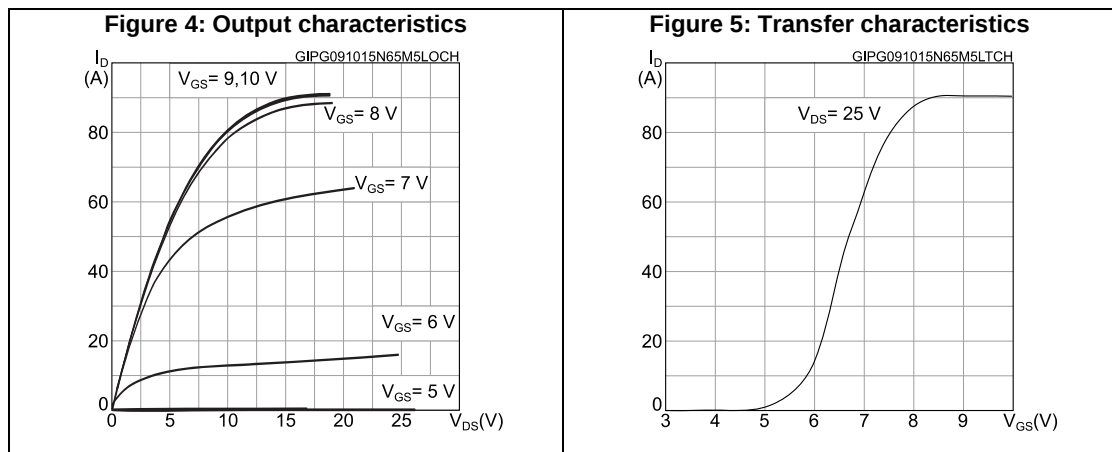
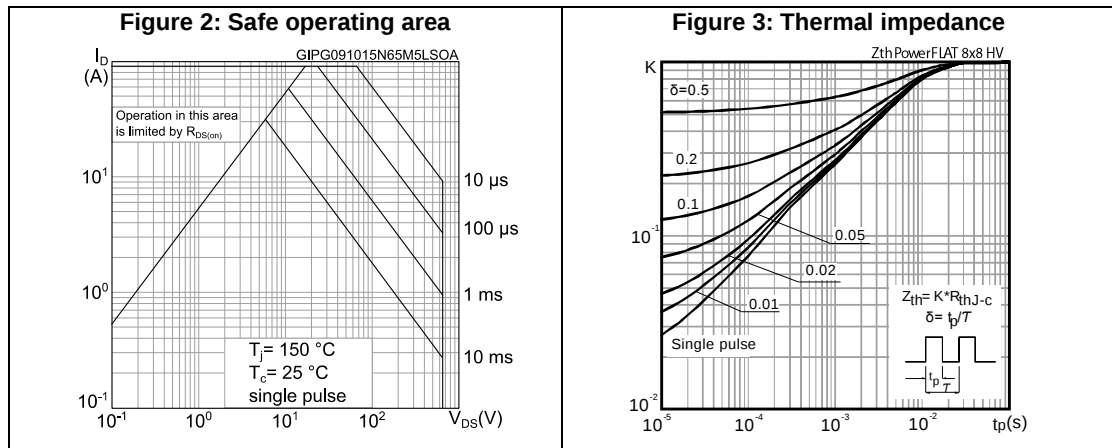


Figure 8: Capacitance variations

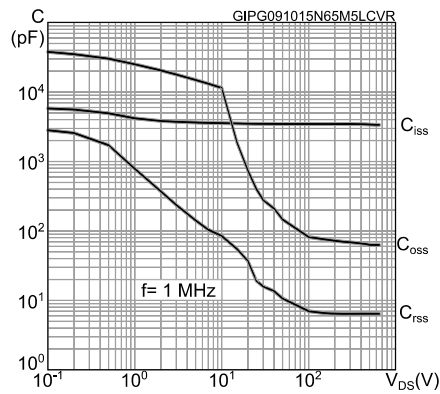


Figure 9: Output capacitance stored energy

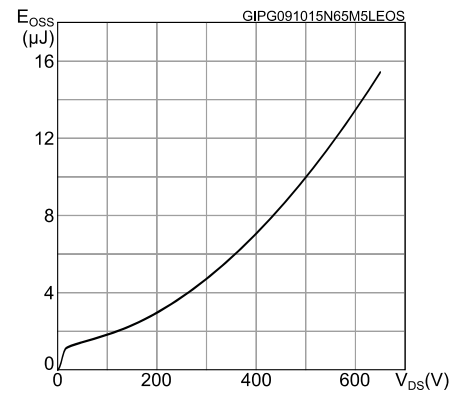


Figure 10: Normalized gate threshold voltage vs temperature

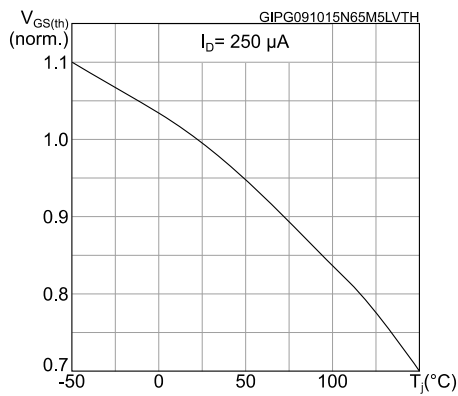


Figure 11: Normalized on-resistance vs. temperature

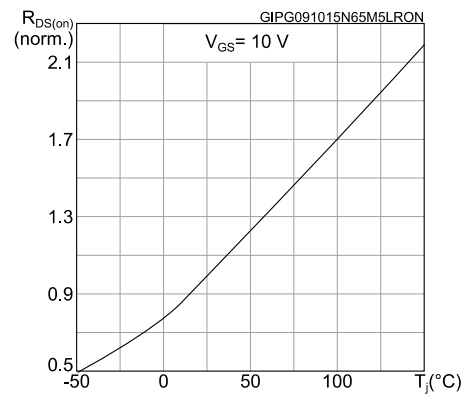


Figure 12: Drain-source diode forward characteristics

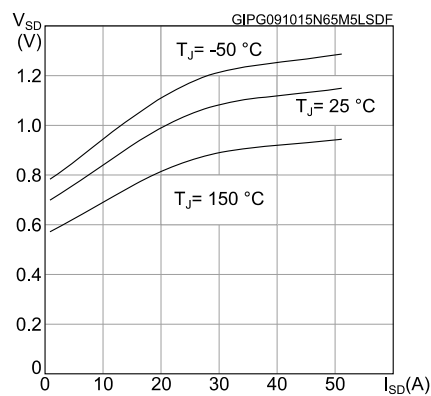


Figure 13: Normalized V(BR)DSS vs temperature

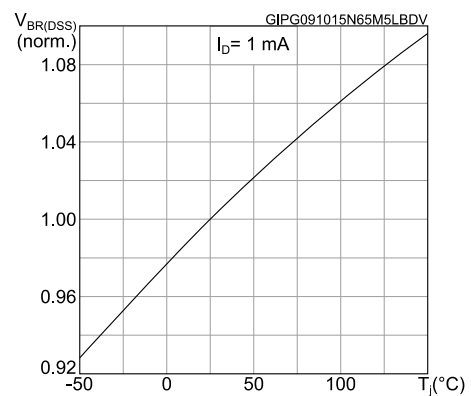
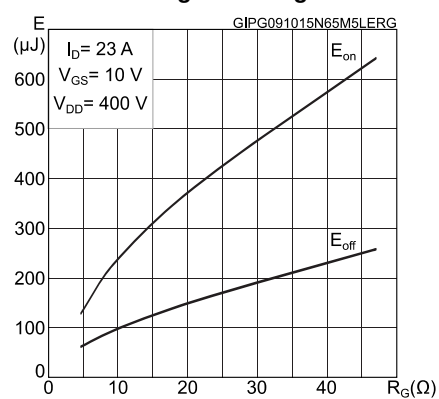
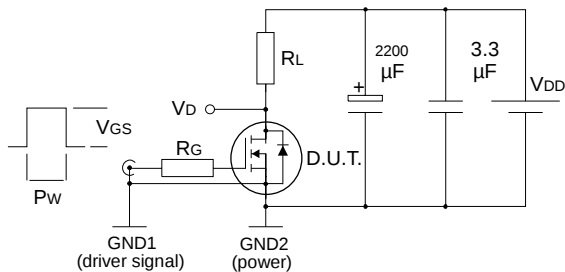


Figure 14: Switching loss vs. gate resistance<sup>(1)</sup>**Notes:**

<sup>(1)</sup> $E_{on}$  including reverse recovery of a SiC diode

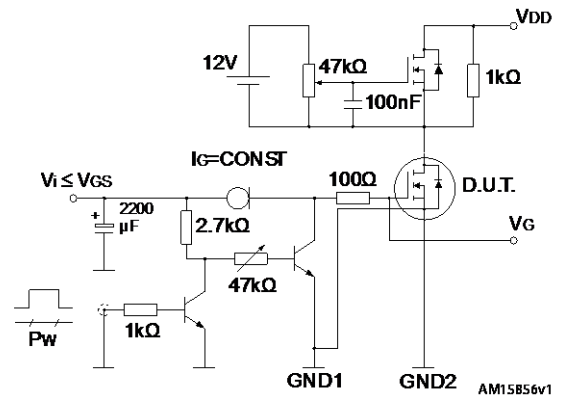
### 3 Test circuits

Figure 15: Switching times test circuit for resistive load



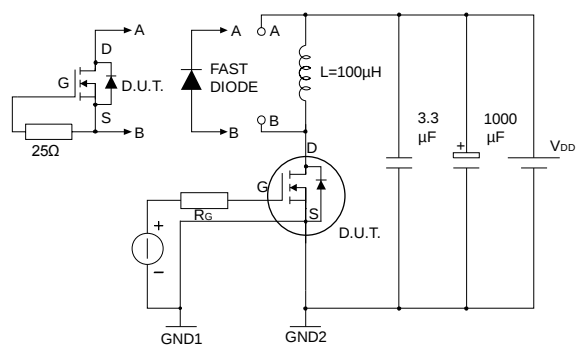
AM15855v1

Figure 16: Gate charge test circuit



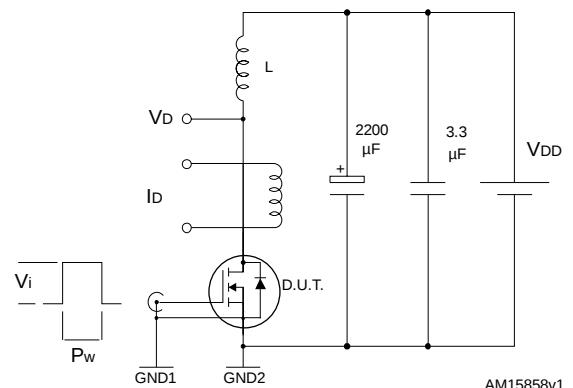
AM15856v1

Figure 17: Test circuit for inductive load switching and diode recovery times



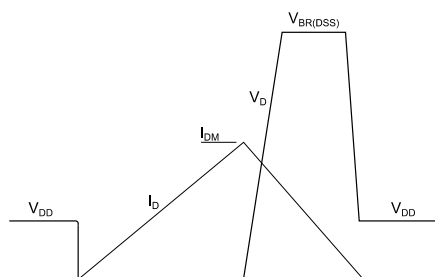
AM15857v1

Figure 18: Unclamped inductive load test circuit



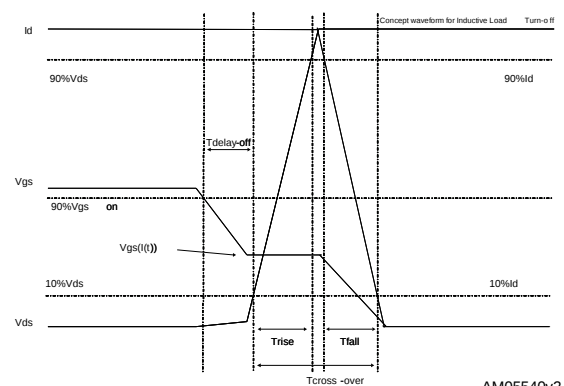
AM15858v1

Figure 19: Unclamped inductive waveform



AM01472v1

Figure 20: Switching time waveform



AM05540v2

## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **[www.st.com](http://www.st.com)**. ECOPACK® is an ST trademark.

## 4.1 PowerFLAT 8x8 HV package information

Figure 21: PowerFLAT™ 8x8 HV package outline

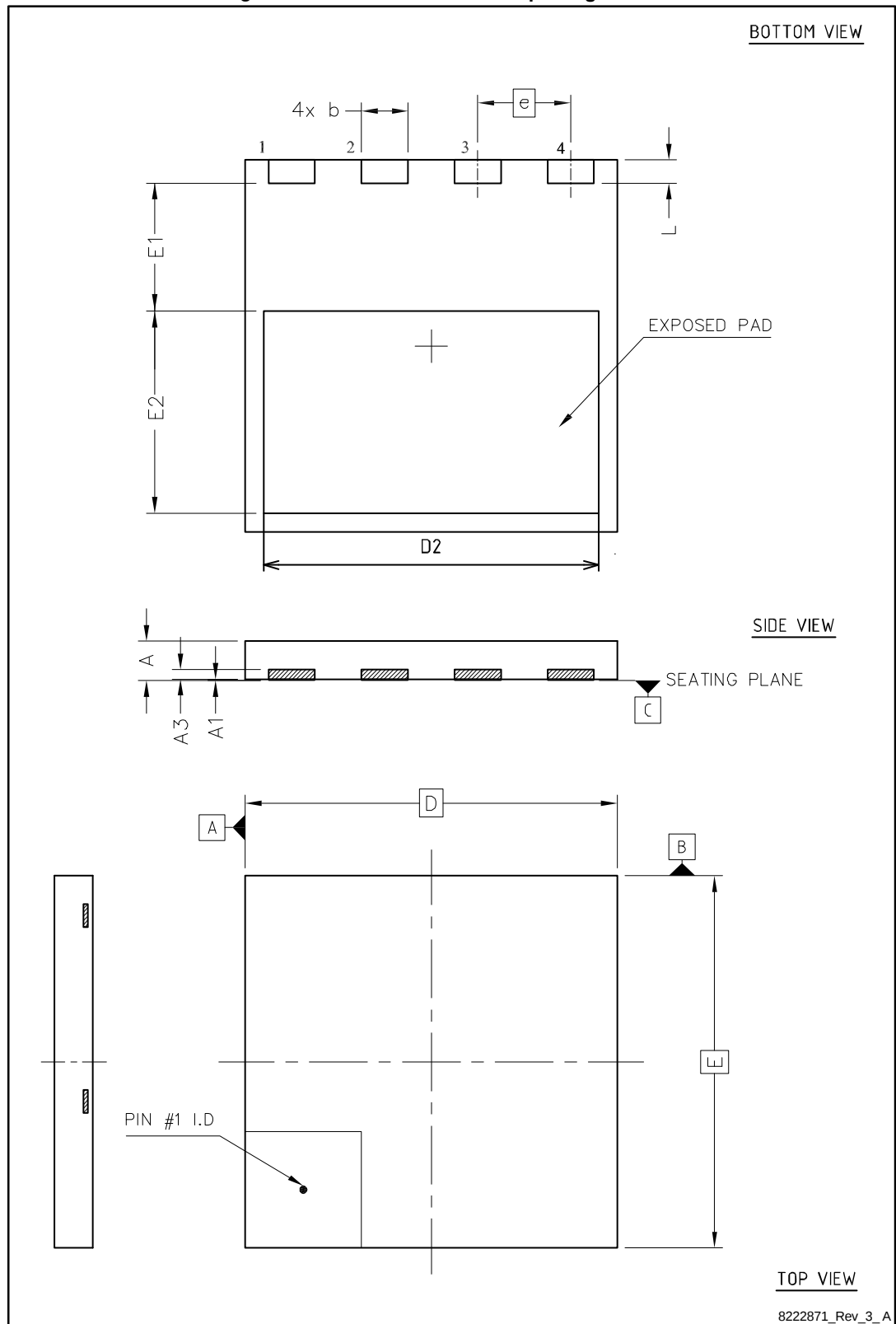
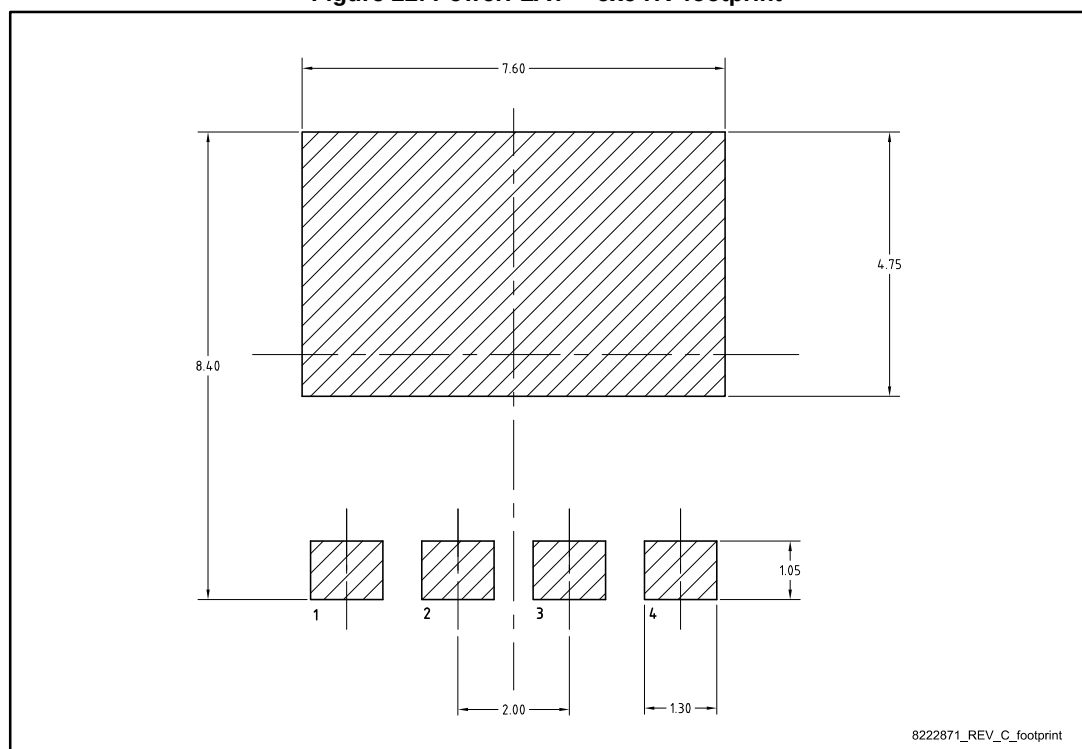


Table 9: PowerFLAT™ 8x8 HV mechanical data

| Dim. | mm   |      |      |
|------|------|------|------|
|      | Min. | Typ. | Max. |
| A    | 0.75 | 0.85 | 0.95 |
| A1   | 0.00 |      | 0.05 |
| A3   | 0.10 | 0.20 | 0.30 |
| b    | 0.90 | 1.00 | 1.10 |
| D    | 7.90 | 8.00 | 8.10 |
| E    | 7.90 | 8.00 | 8.10 |
| D2   | 7.10 | 7.20 | 7.30 |
| E1   | 2.65 | 2.75 | 2.85 |
| E2   | 4.25 | 4.35 | 4.45 |
| e    |      | 2.00 |      |
| L    | 0.40 | 0.50 | 0.60 |

Figure 22: PowerFLAT™ 8x8 HV footprint



All dimensions are in millimeters.

## 4.2 PowerFLAT 8x8 HV packing information

Figure 23: PowerFLAT™ 8x8 HV tape

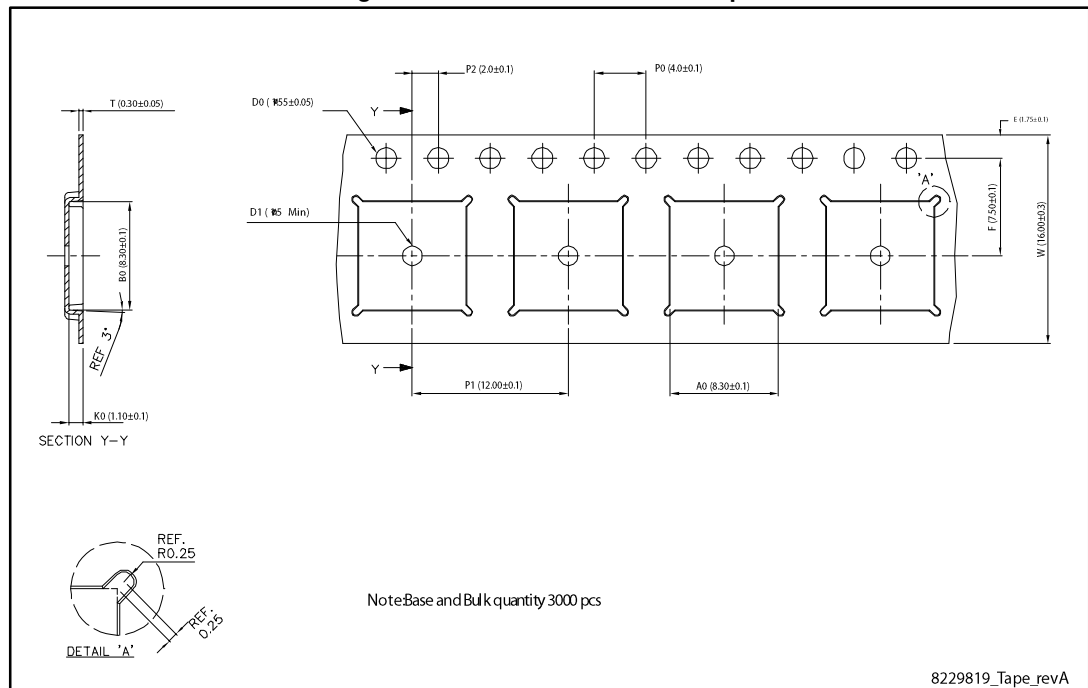


Figure 24: PowerFLAT™ 8x8 HV package orientation in carrier tape

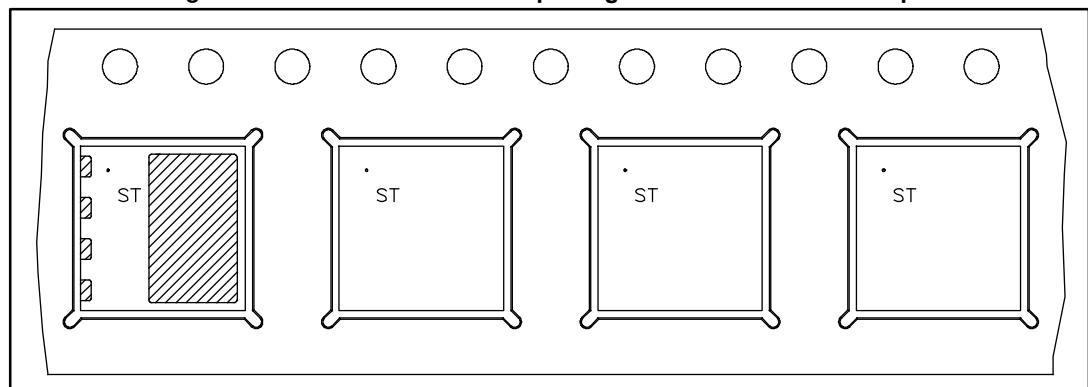
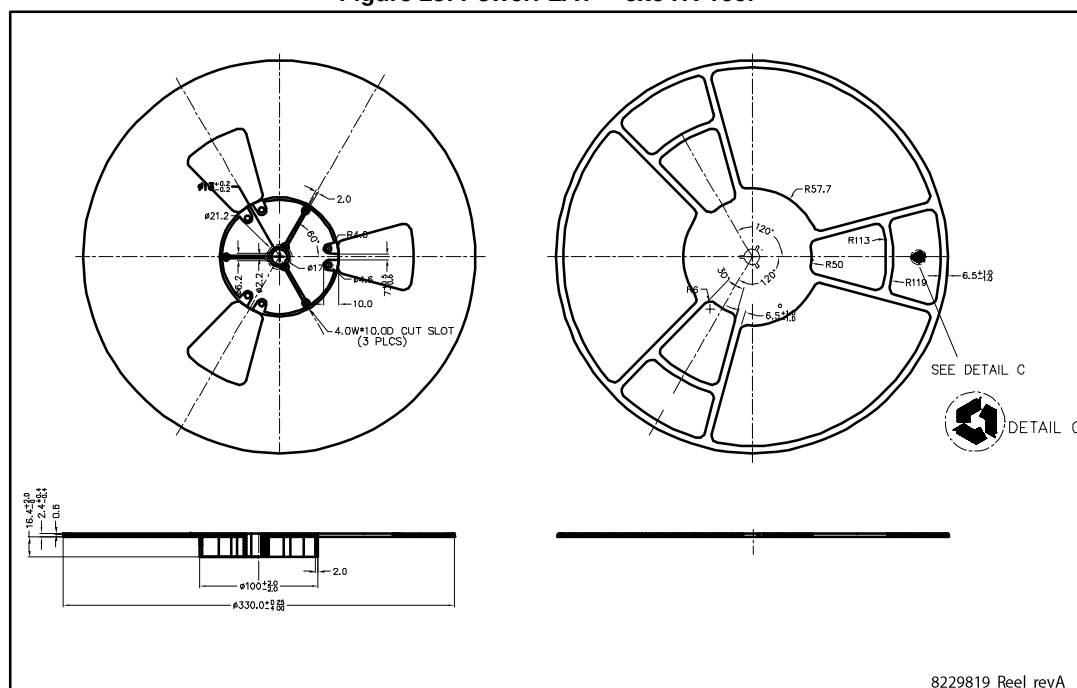


Figure 25: PowerFLAT™ 8x8 HV reel



## 5 Revision history

**Table 10: Document revision history**

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                 |
|-------------|----------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 20-Sep-2012 | 1        | First release.                                                                                                                                                                                                                                                                                                                                                                                          |
| 09-Oct-2015 | 2        | Text and formatting changes throughout document<br>Datasheet status changed from preliminary to production data<br>In section Electrical ratings:<br>- added table Avalanche characteristics<br>In section Electrical characteristics:<br>- renamed table Static (was On /off states)<br>Updated section Test circuits<br>Updated and renamed section Package information (was Package mechanical data) |

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